

## Application/Control No.

Applicant(s)/Patent under Reexamination

10/829,248 Examiner Alex Liew NAKASHIMA ET AL.

2624

SEARCHED					
Class	Subclass	Date	Examiner		
			+		
			-		
		-			
			-		
			+		

Class	Subclass	Date	Examine
			-
			1
			T

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
382/103, 104, 107, 115, 118, 206, 236, 282, 299 limited to text search	7/22/2007	AL		
382/103, 104, 107, 115, 118, 206, 236, 282, 299 limited to text search	1/24/2008	AL		
		æ		